Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,554	PHAM, HIEP THE	
Examiner	Art Unit	
Hai I Nguyen	2816	

	SEARCHED				
Class		Subclass	Date	Examiner	
3	27	156,157, 162,163, 146-148	4/27/2005	HLN	
		3,5,7,12			
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	/	71-77			
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
Search	Above	4/29/2005	HLN			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Shepardize Search	4/28/2005	HLN		
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